

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
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Examiner		Art Unit		Page 1 of 1
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,282,277 b1	08-2001	DeBalko, George Andrew	379/221.02
*	C	US-6,823,064 b1	11-2004	Korman et al.	379/333
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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